



EV317155787

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

#23/E
8/5/03
Suler

Application Serial No. 09/875,501
Filing Date June 4, 2001
Inventor Klaus F. Schu graf t al.
Assignee Micron Technology, Inc.
Group Art Unit 2815
Examiner E. Ortiz
Attorney's Docket No. MI22-1741
Title: Methods for Forming Wordlines, Transistor Gates, and Conductive
Interconnects, and Wordline, Transistor Gate, and Conductive Interconnect
Structures

**RESPONSE TO MARCH 19, 2003 FINAL OFFICE ACTION
ACCOMPANYING REQUEST FOR CONTINUED EXAMINATION (RCE)**

To: Mail Stop RCE
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

From: D. Brent Kenady
Tel. 509-624-4276; Fax 509-838-3424
Wells St. John P.S.
601 West First Avenue, Suite 1300
Spokane, WA 99201-3828

Responsive to the Final Office Action dated March 19, 2003, Applicant
amends and remarks as follows:

AMENDMENTS

Underlines indicate insertions and ~~strikeouts~~ indicate deletions.